

54AC00 • 54ACT00 Quad 2-Input NAND Gate

General Description

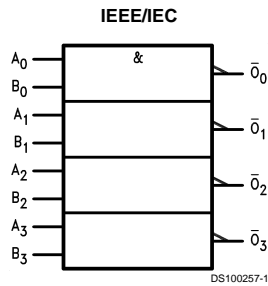
The 'AC/'ACT00 contains four 2-input NAND gates.

Features

- I_{CC} reduced by 50%

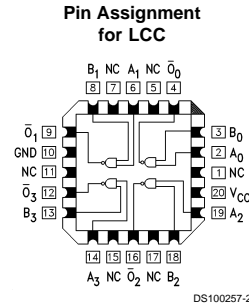
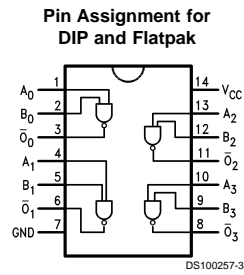
- Outputs source/sink 24 mA
- 'ACT00 has TTL-compatible inputs
- Standard Microcircuit Drawing (SMD)
 - 'AC00: 5962-87549
 - 'ACT00: 5962-87699

Logic Symbol



| Pin Names | Description |
|------------|-------------|
| A_n, B_n | Inputs |
| O_n | Outputs |

Connection Diagrams



Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

| | |
|--|--------------------------|
| Supply Voltage (V_{CC}) | -0.5V to +7.0V |
| DC Input Diode Current (I_{IK}) | |
| $V_I = -0.5V$ | -20 mA |
| $V_I = V_{CC} + 0.5V$ | +20 mA |
| DC Input Voltage (V_I) | -0.5V to $V_{CC} + 0.5V$ |
| DC Output Diode Current (I_{OK}) | |
| $V_O = -0.5V$ | -20 mA |
| $V_O = V_{CC} + 0.5V$ | +20 mA |
| DC Output Voltage (V_O) | -0.5V to $V_{CC} + 0.5V$ |
| DC Output Source or Sink Current (I_O) | ±50 mA |
| DC V_{CC} or Ground Current per Output Pin (I_{CC} or I_{GND}) | ±50 mA |
| Storage Temperature (T_{STG}) | -65°C to +150°C |
| Junction Temperature (T_J) | |
| CDIP | 175°C |

Recommended Operating Conditions

| | |
|---|-----------------|
| Supply Voltage (V_{CC}) | |
| 'AC | 2.0V to 6.0V |
| 'ACT | 4.5V to 5.5V |
| Input Voltage (V_I) | 0V to V_{CC} |
| Output Voltage (V_O) | 0V to V_{CC} |
| Operating Temperature (T_A) | |
| 54AC/ACT | -55°C to +125°C |
| Minimum Input Edge Rate ($\Delta V/\Delta t$) | |
| 'AC Devices | |
| V_{IN} from 30% to 70% of V_{CC} | |
| V_{CC} @ 3.3V, 4.5V, 5.5V | 125 mV/ns |
| Minimum Input Edge Rate ($\Delta V/\Delta t$) | |
| 'ACT Devices | |
| V_{IN} from 0.8V to 2.0V | |
| V_{CC} @ 4.5V, 5.5V | 125 mV/ns |

Note 1: Absolute maximum ratings are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. National does not recommend operation of FACT® circuits outside databook specifications.

DC Characteristics for 'AC Family Devices

| Symbol | Parameter | V_{CC} (V) | 54AC | Units | Conditions | |
|-----------|---|-----------------|----------------------------|-------|--|--|
| | | | $T_A =$ -55°C to +125°C | | | |
| | | | Guaranteed Limits | | | |
| V_{IH} | Minimum High Level Input Voltage | 3.0 | 2.1 | V | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$ | |
| | | 4.5 | 3.15 | | | |
| | | 5.5 | 3.85 | | | |
| V_{IL} | Maximum Low Level Input Voltage | 3.0 | 0.9 | V | $V_{OUT} = 0.1V$ or $V_{CC} - 0.1V$ | |
| | | 4.5 | 1.35 | | | |
| | | 5.5 | 1.65 | | | |
| V_{OH} | Minimum High Level Output Voltage | 3.0 | 2.9 | V | $I_{OUT} = -50 \mu A$ | |
| | | 4.5 | 4.4 | | | |
| | | 5.5 | 5.4 | | | |
| | | | 3.0 | 2.4 | V | (Note 2) $V_{IN} = V_{IL}$ or V_{IH} $I_{OH} = -12 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ $I_{OH} = -24 \text{ mA}$ |
| | | | 4.5 | 3.7 | | |
| | | | 5.5 | 4.7 | | |
| V_{OL} | Maximum Low Level Output Voltage | 3.0 | 0.1 | V | $I_{OUT} = 50 \mu A$ | |
| | | 4.5 | 0.1 | | | |
| | | 5.5 | 0.1 | | | |
| | | | 3.0 | 0.5 | V | (Note 2) $V_{IN} = V_{IL}$ or V_{IH} $I_{OL} = 12 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ |
| | | | 4.5 | 0.5 | | |
| | | | 5.5 | 0.5 | | |
| I_{IN} | Maximum Input Leakage Current | 5.5 | ±1.0 | μA | $V_I = V_{CC}, GND$ | |
| I_{OLD} | Minimum Dynamic Output Current (Note 4) | 5.5 | 50 | mA | $V_{OLD} = 1.65V \text{ Max}$ | |
| I_{OHD} | | 5.5 | -50 | mA | $V_{OHD} = 3.85V \text{ Min}$ | |
| I_{CC} | | 5.5 | 40.0 | μA | $V_{IN} = V_{CC}$ | |

DC Characteristics for 'AC Family Devices (Continued)

| Symbol | Parameter | V _{CC} (V) | 54AC | Units | Conditions |
|--------|----------------|------------------------|-------------------------------------|-------|------------|
| | | | T _A = -55°C to +125°C | | |
| | | | Guaranteed Limits | | |
| | Supply Current | | | | or GND |

Note 2: All outputs loaded; thresholds on input associated with output under test.

Note 3: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC}.

I_{CC} for 54AC @ 25°C is identical to 74AC @ 25°C.

Note 4: Maximum test duration 2.0 ms, one output loaded at a time.

Note 5: I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC}.

I_{CC} for 54AC @ 25°C is identical to 74AC @ 25°C.

DC Characteristics for 'ACT Family Devices

| Symbol | Parameter | V _{CC} (V) | 54ACT | Units | Conditions |
|------------------|--|------------------------|-------------------------------------|-------|--|
| | | | T _A = -55°C to +125°C | | |
| | | | Guaranteed Limits | | |
| V _{IH} | Minimum High Level Input Voltage | 4.5 | 2.0 | V | V _{OUT} = 0.1V or V _{CC} - 0.1V |
| | | 5.5 | 2.0 | | |
| V _{IL} | Maximum Low Level Input Voltage | 4.5 | 0.8 | V | V _{OUT} = 0.1V or V _{CC} - 0.1V |
| | | 5.5 | 0.8 | | |
| V _{OH} | Minimum High Level Output Voltage | 4.5 | 4.4 | V | I _{OUT} = -50 μA |
| | | 5.5 | 5.4 | | |
| | | 4.5 | 3.70 | V | (Note 6) V _{IN} = V _{IL} or V _{IH} I _{OH} = -24 mA I _{OH} = -24 mA |
| | | 5.5 | 4.70 | | |
| V _{OL} | Maximum Low Level Output Voltage | 4.5 | 0.1 | V | I _{OUT} = 50 μA |
| | | 5.5 | 0.1 | | |
| | | 4.5 | 0.50 | V | (Note 6) V _{IN} = V _{IL} or V _{IH} I _{OL} = 24 mA I _{OL} = 24 mA |
| | | 5.5 | 0.50 | | |
| I _{IN} | Maximum Input Leakage Current | 5.5 | ±1.0 | μA | V _I = V _{CC} , GND |
| I _{CCT} | Maximum I _{CC} /Input | 5.5 | 1.6 | mA | V _I = V _{CC} - 2.1V |
| I _{OLD} | Minimum Dynamic Output Current (Note 7) | 5.5 | 50 | mA | V _{OLD} = 1.65V Max |
| I _{OHD} | | 5.5 | -50 | mA | V _{OHD} = 3.85V Min |
| I _{CC} | Maximum Quiescent Supply Current | 5.5 | 40.0 | μA | V _{IN} = V _{CC} or GND |

Note 6: All outputs loaded; thresholds on input associated with output under test.

Note 7: Maximum test duration 2.0 ms, one output loaded at a time.

Note 8: I_{CC} for 54ACT @ 25°C is identical to 74ACT @ 25°C.

AC Electrical Characteristics

| Symbol | Parameter | V _{CC} (V) (Note 9) | 54AC | | Units | Fig. No. |
|------------------|-------------------|------------------------------------|---|-------------|-------|-------------|
| | | | T _A = -55°C to +125°C C _L = 50 pF | | | |
| | | | Min | Max | | |
| t _{PLH} | Propagation Delay | 3.3 5.0 | 1.0 1.5 | 11.0 8.5 | ns | |
| t _{PHL} | Propagation Delay | 3.3 5.0 | 1.0 1.5 | 9.0 7.0 | ns | |

Note 9: Voltage Range 3.3 is 3.3V ±0.3V
Voltage Range 5.0 is 5.0V ±0.5V

AC Electrical Characteristics

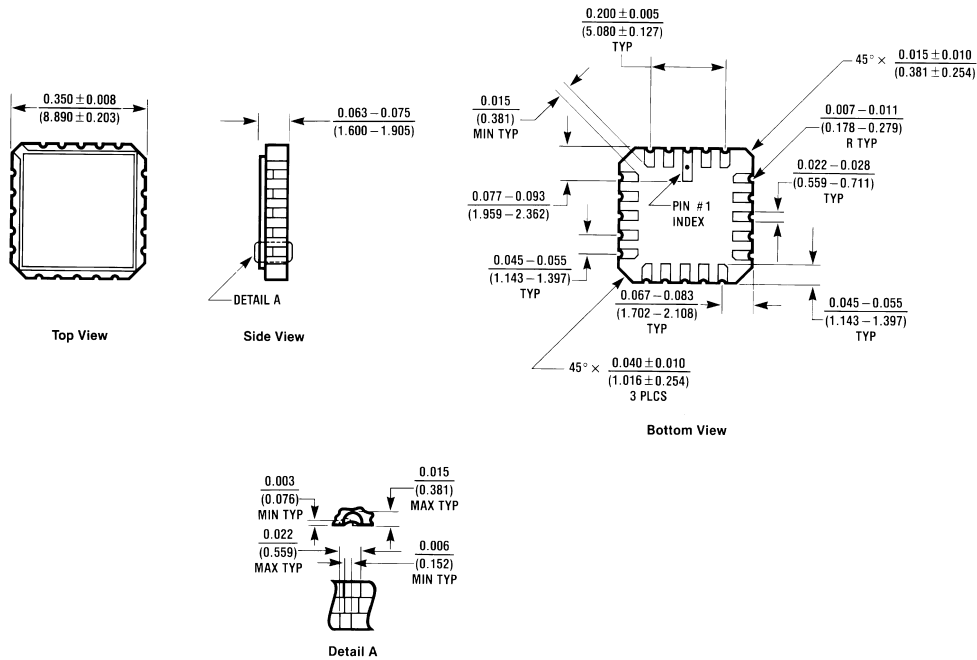
| Symbol | Parameter | V _{CC} (V) (Note 10) | 54ACT | | Units | Fig. No. |
|------------------|-------------------|-------------------------------------|---|-----|-------|-------------|
| | | | T _A = -55°C to +125°C C _L = 50 pF | | | |
| | | | Min | Max | | |
| t _{PLH} | Propagation Delay | 5.0 | 1.5 | 9.5 | ns | |
| t _{PHL} | Propagation Delay | 5.0 | 1.5 | 8.0 | ns | |

Note 10: Voltage Range 5.0 is 5.0V ±0.5V

Capacitance

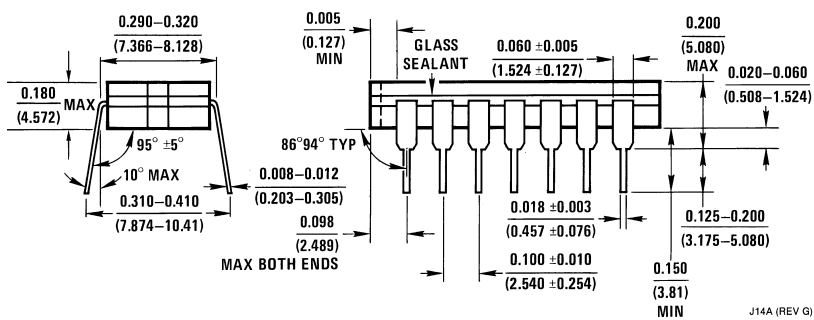
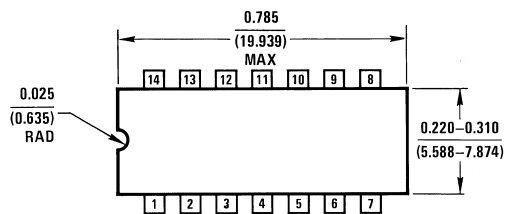
| Symbol | Parameter | Typ | Units | Conditions |
|-----------------|----------------------------------|------|-------|------------------------|
| C _{IN} | Input Capacitance | 4.5 | pF | V _{CC} = Open |
| C _{PD} | Power Dissipation Capacitance | 30.0 | pF | V _{CC} = 5.0V |

Physical Dimensions inches (millimeters) unless otherwise noted



E20A (REV D)

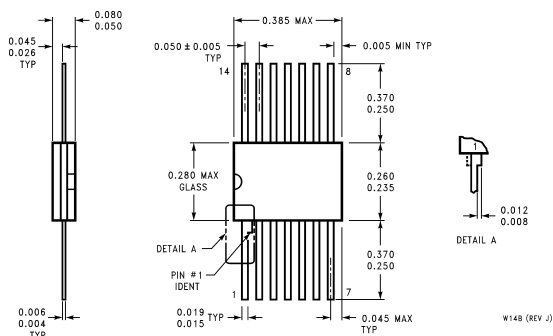
20 Terminal Ceramic Leadless Chip Carrier (L)
NS Package Number E20A



J14A (REV G)

14 Lead Ceramic Dual-In-Line Package (D)
NS Package Number J14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



**14 Lead Ceramic Flatpak (F)
NS Package Number W14B**

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National Semiconductor Corporation
Americas
Tel: 1-800-272-9959
Fax: 1-800-737-7018
Email: support@nsc.com

www.national.com

National Semiconductor Europe
Fax: +49 (0) 1 80-530 85 86
Email: europe.support@nsc.com
Deutsch Tel: +49 (0) 1 80-530 85 85
English Tel: +49 (0) 1 80-532 78 32
Français Tel: +49 (0) 1 80-532 93 58
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National Semiconductor Asia Pacific Customer Response Group
Tel: 65-2544466
Fax: 65-2504466
Email: sea.support@nsc.com

National Semiconductor Japan Ltd.
Tel: 81-3-5639-7560
Fax: 81-3-5639-7507